

# **Notice of References Cited**

Application/Control No.

10/055,438

Applicant(s)/Patent Under

Reexamination

DE SCHRYVER ET AL.

Examiner

Peter Szekeley

Art Unit

1714

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## **U.S. PATENT DOCUMENTS**

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	B	US-5,656,371	08-1997	Kawahigashi et al.	428/375
	C	US-5,760,120 A	06-1998	Itoh et al.	524/431
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	L	US-			
	M	US-			

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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